

NTMSD3P303R2

FETKY™

P-Channel Enhancement-Mode Power MOSFET and Schottky Diode Dual SO-8 Package

Features

- High Efficiency Components in a Single SO-8 Package
- High Density Power MOSFET with Low $R_{DS(on)}$, Schottky Diode with Low V_F
- Independent Pin-Outs for MOSFET and Schottky Die Allowing for Flexibility in Application Use
- Less Component Placement for Board Space Savings
- SO-8 Surface Mount Package, Mounting Information for SO-8 Package Provided

Applications

- DC-DC Converters
- Low Voltage Motor Control
- Power Management in Portable and Battery-Powered Products, i.e.: Computers, Printers, PCMCIA Cards, Cellular and Cordless Telephones

MOSFET MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DS}	-30	V
Gate-to-Source Voltage - Continuous	V_{GS}	± 20	V
Thermal Resistance - Junction-to-Ambient (Note 1.) Total Power Dissipation @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 70^\circ\text{C}$ Pulsed Drain Current (Note 4.)	$R_{\theta JA}$ P_D I_D I_D I_{DM}	171 0.73 -2.34 -1.87 -8.0	$^\circ\text{C/W}$ W A A A
Thermal Resistance - Junction-to-Ambient (Note 2.) Total Power Dissipation @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 70^\circ\text{C}$ Pulsed Drain Current (Note 4.)	$R_{\theta JA}$ P_D I_D I_D I_{DM}	100 1.25 -3.05 -2.44 -12	$^\circ\text{C/W}$ W A A A
Thermal Resistance - Junction-to-Ambient (Note 3.) Total Power Dissipation @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 70^\circ\text{C}$ Pulsed Drain Current (Note 4.)	$R_{\theta JA}$ P_D I_D I_D I_{DM}	62.5 2.0 -3.86 -3.10 -15	$^\circ\text{C/W}$ W A A A
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to +150	$^\circ\text{C}$
Single Pulse Drain-to-Source Avalanche Energy - Starting $T_J = 25^\circ\text{C}$ ($V_{DD} =$ -30 Vdc, $V_{GS} = -4.5$ Vdc, Peak $I_L =$ -7.5 Apk, $L = 5$ mH, $R_G = 25 \Omega$)	E_{AS}	140	mJ
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T_L	260	$^\circ\text{C}$

1. Minimum FR-4 or G-10 PCB, Steady State.
2. Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), Steady State.
3. Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), $t \leq 10$ seconds.
4. Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%.

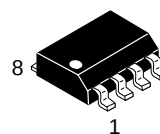


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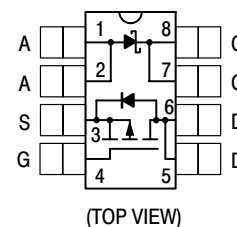
<http://onsemi.com>

MOSFET
-3.05 AMPERES
-30 VOLTS
0.085 Ω @ $V_{GS} = -10$ V

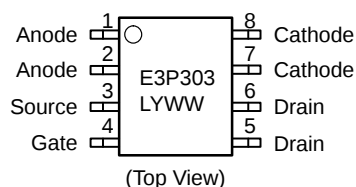
SCHOTTKY DIODE
3.0 AMPERES
30 VOLTS
420 mV @ $I_F = 3.0$ A



SO-8
CASE 751
STYLE 18



MARKING DIAGRAM & PIN ASSIGNMENTS



E3P303 = Device Code
L = Assembly Location
Y = Year
WW = Work Week

ORDERING INFORMATION

Device	Package	Shipping†
NTMSD3P303R2	SO-8	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

NTMSD3P303R2

SCHOTTKY MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Reverse Voltage DC Blocking Voltage	V_{RRM} V_R	30	V
Thermal Resistance – Junction-to-Ambient (Note 5.)	$R_{\theta JA}$	197	$^\circ\text{C/W}$
Thermal Resistance – Junction-to-Ambient (Note 6.)	$R_{\theta JA}$	97	$^\circ\text{C/W}$
Thermal Resistance – Junction-to-Ambient (Note 7.)	$R_{\theta JA}$	62.5	$^\circ\text{C/W}$
Average Forward Current (Note 7.) (Rated V_R , $T_A = 100^\circ\text{C}$)	I_O	3.0	A
Peak Repetitive Forward Current (Note 7.) (Rated V_R , Square Wave, 20 kHz, $T_A = 105^\circ\text{C}$)	I_{FRM}	6.0	A
Non-Repetitive Peak Surge Current (Note 7.) (Surge Applied at Rated Load Conditions, Half-Wave, Single Phase, 60 Hz)	I_{FSM}	30	A

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (Note 8.)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage ($V_{GS} = 0$ Vdc, $I_D = -250$ μAdc) Temperature Coefficient (Positive)	$V_{(BR)DSS}$	-30 -	- -30	- -	Vdc mV/ $^\circ\text{C}$
Zero Gate Voltage Drain Current ($V_{DS} = -30$ Vdc, $V_{GS} = 0$ Vdc, $T_J = 25^\circ\text{C}$) ($V_{DS} = -30$ Vdc, $V_{GS} = 0$ Vdc, $T_J = 125^\circ\text{C}$)	I_{DSS}	- -	- -	-1.0 -25	μAdc
Gate-Body Leakage Current ($V_{GS} = -20$ Vdc, $V_{DS} = 0$ Vdc)	I_{GSS}	-	-	-100	nAdc
Gate-Body Leakage Current ($V_{GS} = +20$ Vdc, $V_{DS} = 0$ Vdc)	I_{GSS}	-	-	100	nAdc

ON CHARACTERISTICS

Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = -250$ μAdc) Temperature Coefficient (Negative)	$V_{GS(th)}$	-1.0 -	-1.7 3.6	-2.5 -	Vdc
Static Drain-to-Source On-State Resistance ($V_{GS} = -10$ Vdc, $I_D = -3.05$ Adc) ($V_{GS} = -4.5$ Vdc, $I_D = -1.5$ Adc)	$R_{DS(on)}$	- -	0.063 0.090	0.085 0.125	Ω
Forward Transconductance ($V_{DS} = -15$ Vdc, $I_D = -3.05$ Adc)	g_{FS}	-	5.0	-	Mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	(V _{DS} = -24 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C_{iss}	-	520	750	pF
Output Capacitance		C_{oss}	-	170	325	
Reverse Transfer Capacitance		C_{rss}	-	70	135	

5. Minimum FR-4 or G-10 PCB, Steady State.

6. Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), Steady State.

7. Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), $t \leq 10$ seconds.

8. Handling precautions to protect against electrostatic discharge is mandatory.

NTMSD3P303R2

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (Note 9.)

Characteristic	Symbol	Min	Typ	Max	Unit
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SWITCHING CHARACTERISTICS (Notes 10. & 11.)

Turn-On Delay Time	$(V_{DD} = -24 \text{ Vdc}, I_D = -3.05 \text{ Adc}, V_{GS} = -10 \text{ Vdc}, R_G = 6.0 \Omega)$	$t_{d(on)}$	–	12	22	ns
Rise Time		t_r	–	16	30	
Turn-Off Delay Time		$t_{d(off)}$	–	45	80	
Fall Time		t_f	–	45	80	
Turn-On Delay Time	$(V_{DD} = -24 \text{ Vdc}, I_D = -1.5 \text{ Adc}, V_{GS} = -4.5 \text{ Vdc}, R_G = 6.0 \Omega)$	$t_{d(on)}$	–	16	–	ns
Rise Time		t_r	–	42	–	
Turn-Off Delay Time		$t_{d(off)}$	–	32	–	
Fall Time		t_f	–	35	–	
Total Gate Charge	$(V_{DS} = -24 \text{ Vdc}, V_{GS} = -10 \text{ Vdc}, I_D = -3.05 \text{ Adc})$	Q_{tot}	–	16	25	nC
Gate-Source Charge		Q_{gs}	–	2.0	–	
Gate-Drain Charge		Q_{gd}	–	4.5	–	

BODY-DRAIN DIODE RATINGS (Note 10.)

Diode Forward On-Voltage	$(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^\circ\text{C})$	V_{SD}	– –	–0.96 –0.78	–1.25 –	Vdc
Reverse Recovery Time	$(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, di_S/dt = 100 \text{ A}/\mu\text{s})$	t_{rr}	–	34	–	ns
		t_a	–	18	–	
		t_b	–	16	–	
Reverse Recovery Stored Charge		Q_{RR}	–	0.03	–	μC

SCHOTTKY RECTIFIER ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (Note 10.)

Maximum Instantaneous Forward Voltage $I_F = 100 \text{ mAdc}$ $I_F = 3.0 \text{ Adc}$ $I_F = 6.0 \text{ Adc}$	V_F	$T_J = 25^\circ\text{C}$	$T_J = 125^\circ\text{C}$	Volts
		0.28	0.13	
		0.42	0.33	
		0.50	0.45	
Maximum Instantaneous Reverse Current $V_R = 30 \text{ Vdc}$	I_R	$T_J = 25^\circ\text{C}$	$T_J = 125^\circ\text{C}$	μA mA
		250	25	
Maximum Voltage Rate of Change $V_R = 30 \text{ Vdc}$	dV/dt	10,000		V/ μs

9. Handling precautions to protect against electrostatic discharge is mandatory.

10. Indicates Pulse Test: Pulse Width = 300 μs max, Duty Cycle = 2%.

11. Switching characteristics are independent of operating junction temperature.

TYPICAL MOSFET ELECTRICAL CHARACTERISTICS

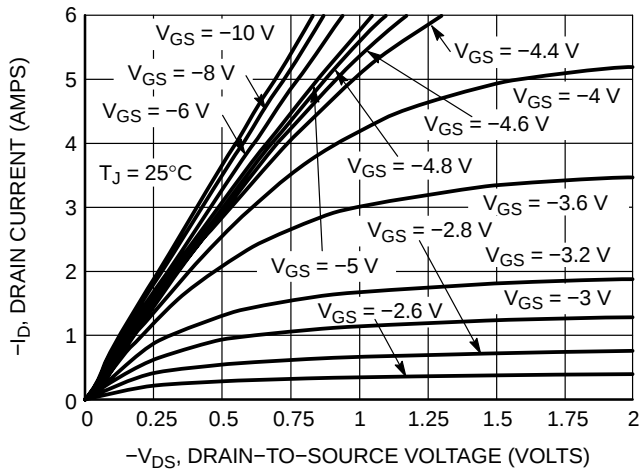


Figure 1. On-Region Characteristics

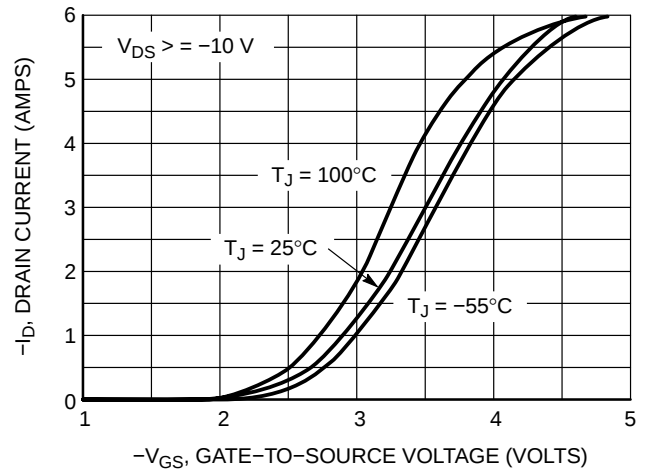


Figure 2. Transfer Characteristics

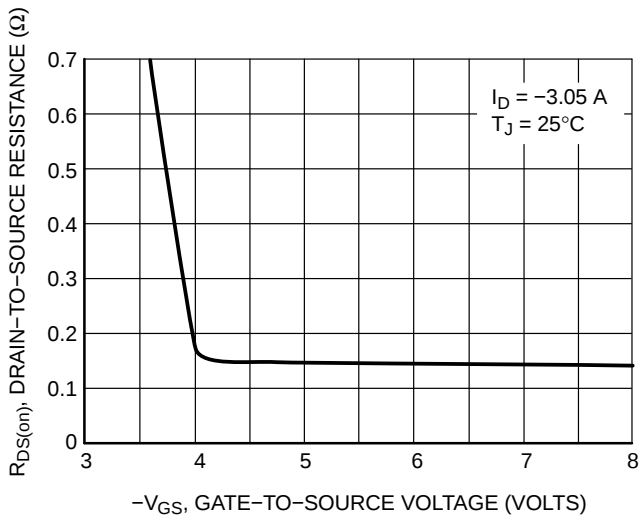


Figure 3. On-Resistance vs. Gate-to-Source Voltage

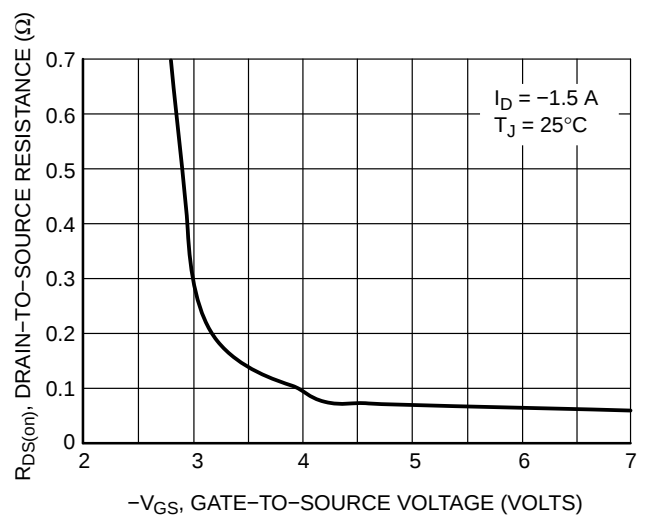


Figure 4. On-Resistance vs. Gate-to-Source Voltage

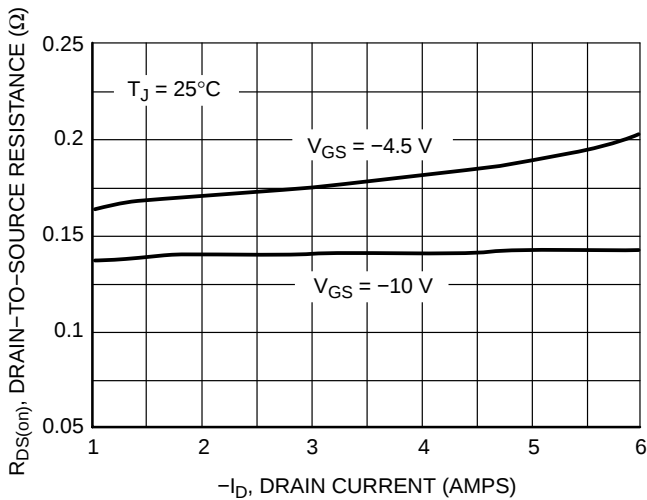


Figure 5. On-Resistance vs. Drain Current and Gate Voltage

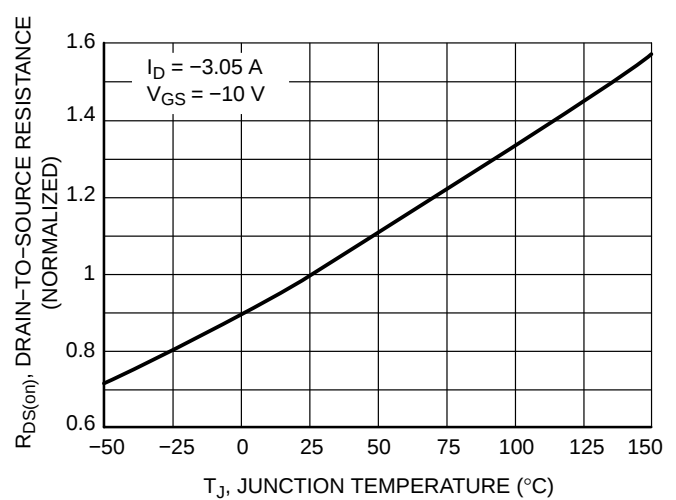


Figure 6. On Resistance Variation with Temperature

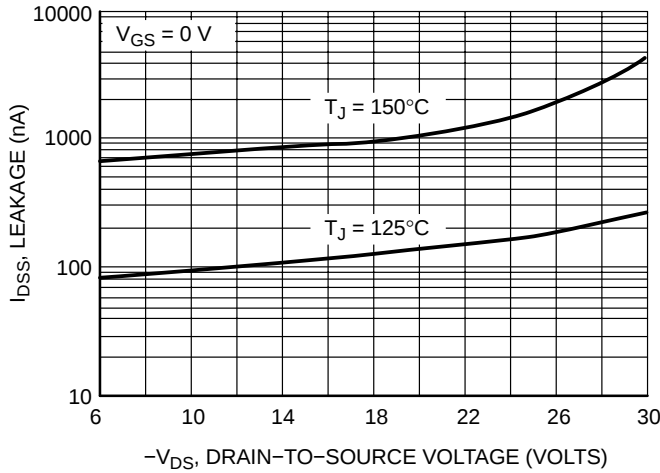


Figure 7. Drain-to-Source Leakage Current vs. Voltage

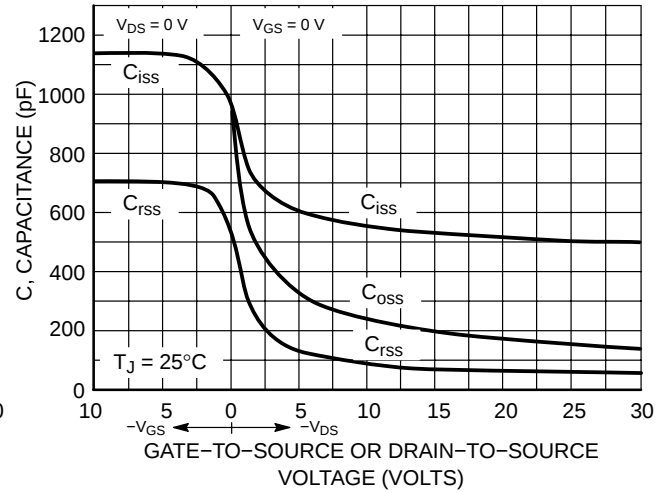


Figure 8. Capacitance Variation

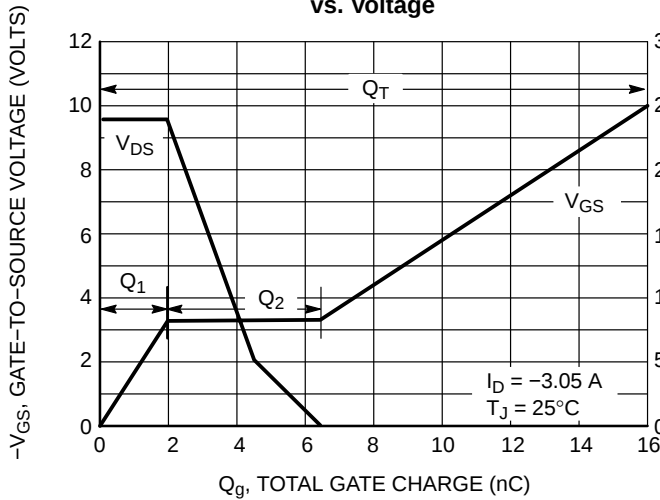


Figure 9. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

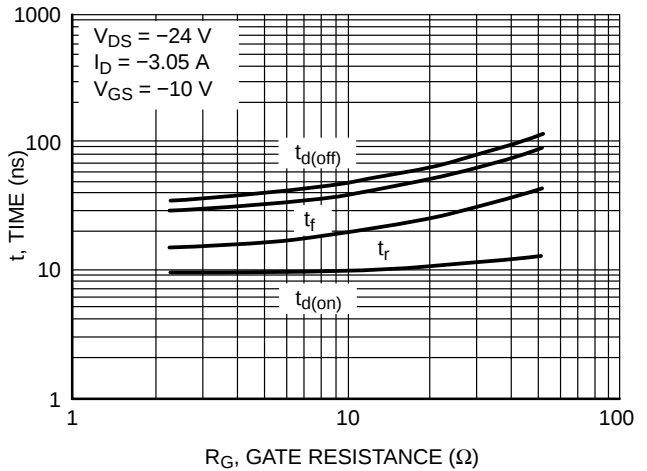


Figure 10. Resistive Switching Time Variation vs. Gate Resistance

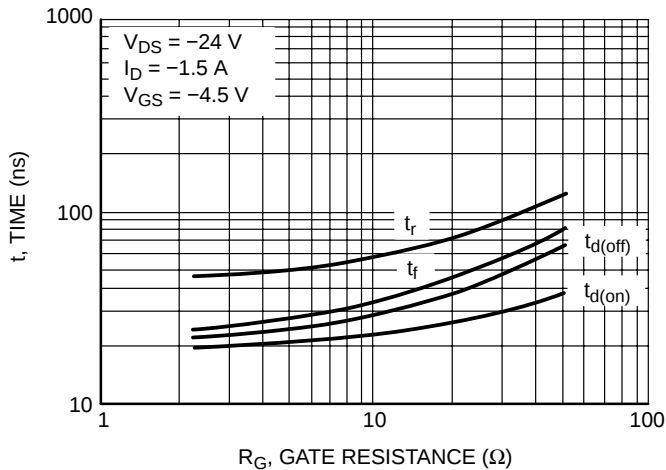


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

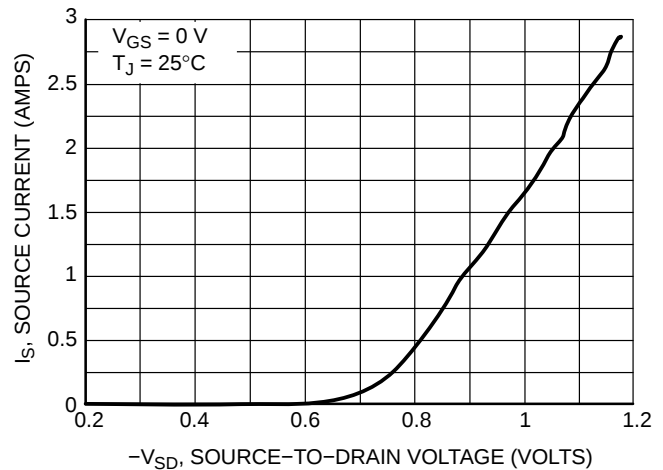


Figure 12. Diode Forward Voltage vs. Current

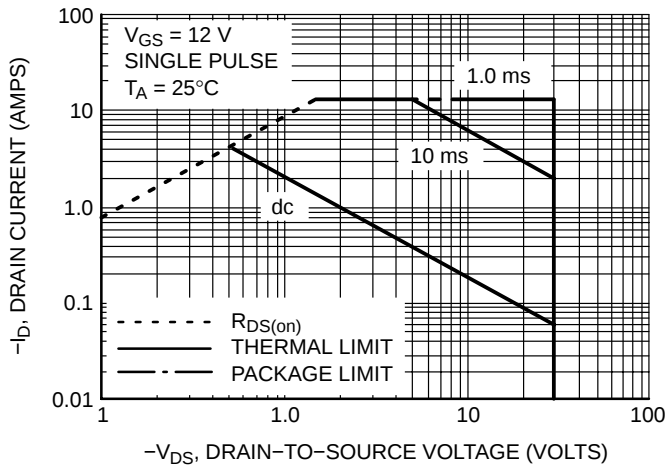


Figure 13. Maximum Rated Forward Biased Safe Operating Area

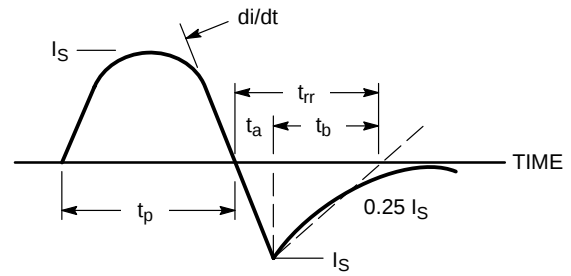


Figure 14. Diode Reverse Recovery Waveform

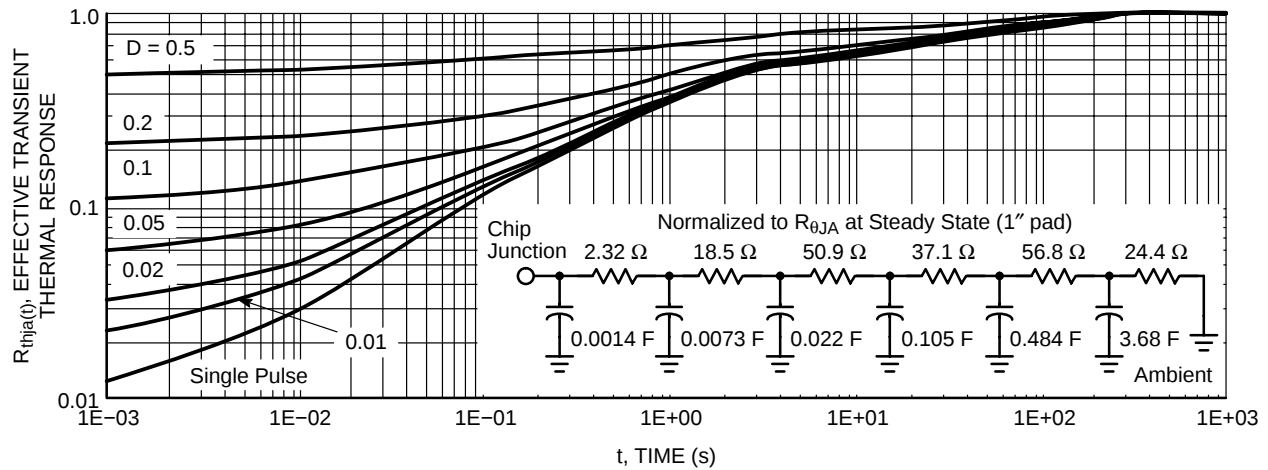


Figure 15. FET Thermal Response

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

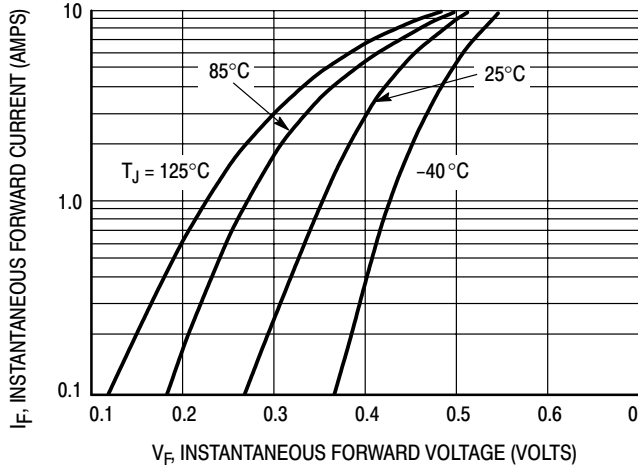


Figure 16. Typical Forward Voltage

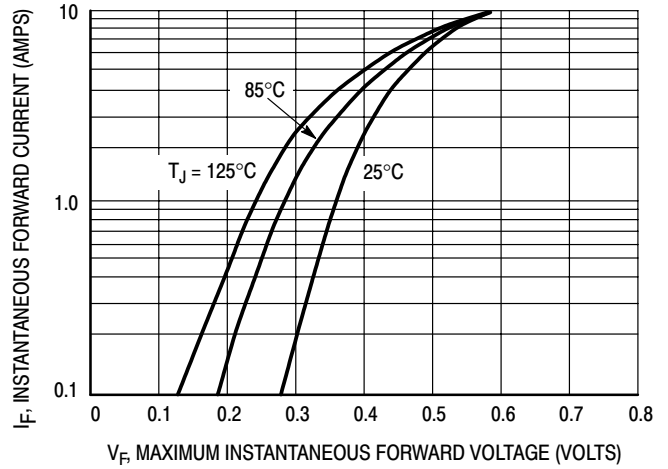


Figure 17. Maximum Forward Voltage

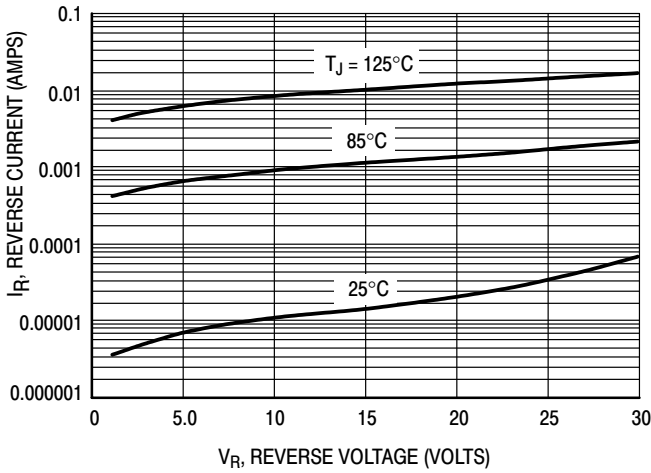


Figure 18. Typical Reverse Current

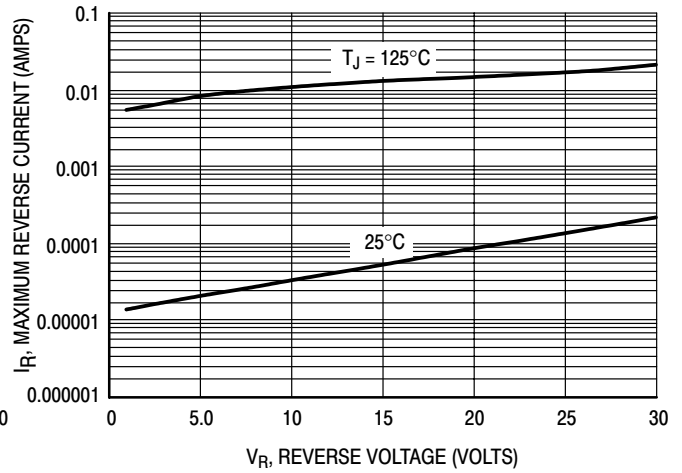


Figure 19. Maximum Reverse Current

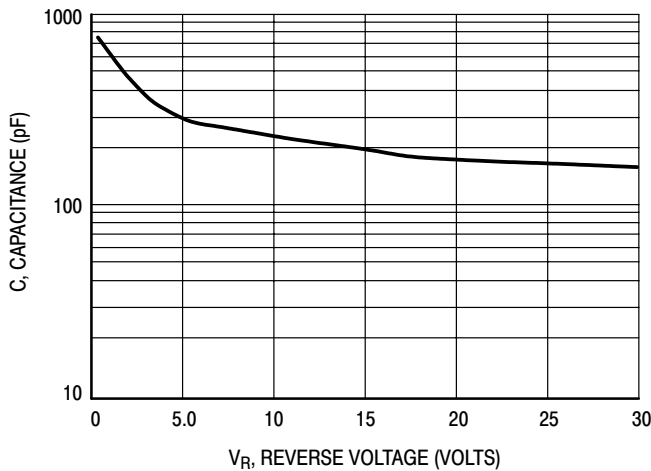


Figure 20. Typical Capacitance

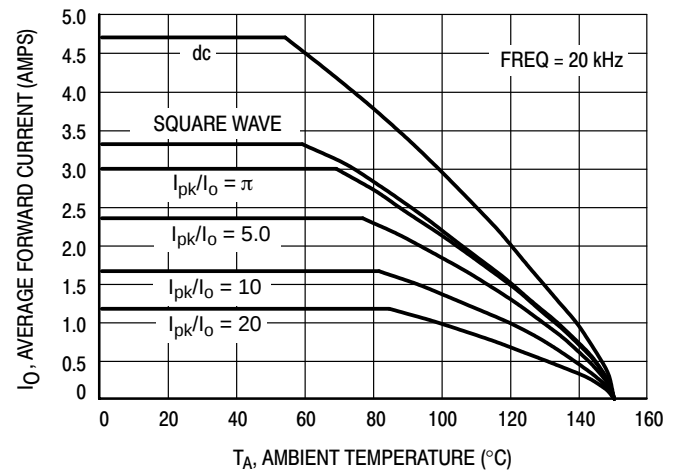


Figure 21. Current Derating

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

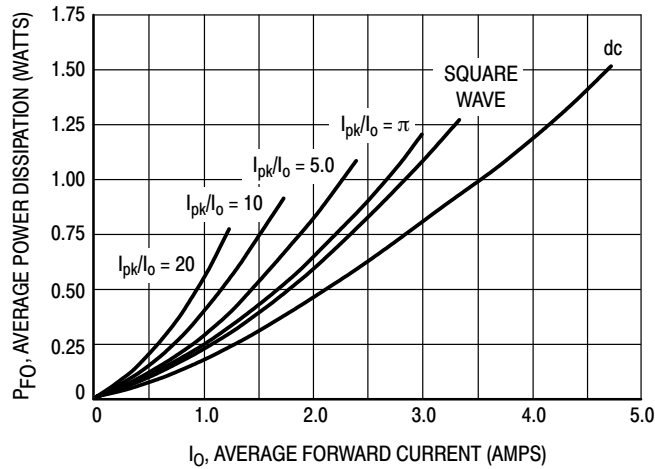


Figure 22. Forward Power Dissipation

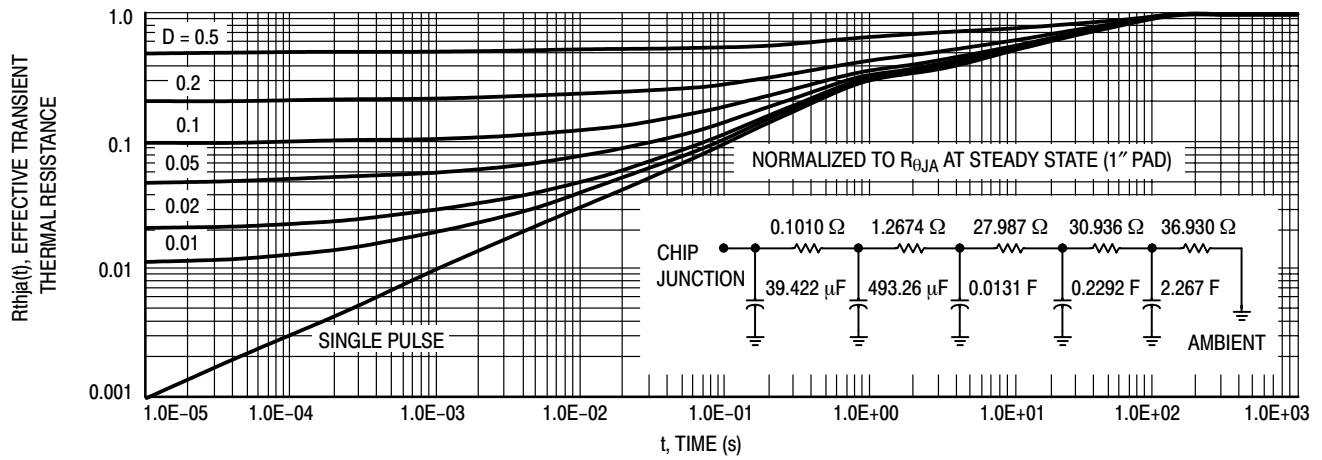


Figure 23. Schottky Thermal Response

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